

Notice of References Cited	Application/Control No. 10/691,882	Applicant(s)/Patent Under Reexamination JAPP ET AL.	
	Examiner Brian P. Egan	Art Unit 1772	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,269,549	05-1981	Block, James P.	408/1R
	B	US-4,929,370	05-1990	Hatch et al.	508/100
	C	US-5,435,671	07-1995	Weinreich, Rudolf W.	408/1R
	D	US-6,355,360	03-2002	Frater, Mark S.	428/607
	E	US-5,227,606	07-1993	Weeks et al.	219/121.67
	F	US-5,507,603	04-1996	Nakano et al.	408/1R
	G	US-4,781,495	11-1988	Hatch et al.	408/1R
	H	US-5,961,255	10-1999	Korbonski, John A.	408/1R
	I	US-6,200,074	03-2001	Miller et al.	408/1R
	J	US-4,311,419	01-1982	Block, James P.	408/1R
	K	US-5,480,269	01-1996	Ejiri et al.	408/1R
	L	US-6,000,886	12-1999	Washio et al.	408/1R
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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